

<b>Notice of References Cited</b>	Application/Control No. 10/729,331	Applicant(s)/Patent Under Reexamination TAN ET AL.	
	Examiner Robert E. Fennema	Art Unit 2183	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,761,470	06-1998	Yoshida, Toyohiko	712/210
*	C	US-4,338,661	07-1982	Tredennick et al.	712/234
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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